



New method of transport measurements on van der Waals heterostructures under pressure

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ABSTRACT

The interlayer coupling, which has a strong influence on the properties of van der Waals heterostructures, strongly depends on the interlayer distance. Although considerable theoretical interest has been demonstrated, experiments exploiting a variable interlayer coupling on nanocircuits are scarce due to the experimental difficulties. Here, we demonstrate a novel method to tune the interlayer coupling using hydrostatic pressure by incorporating van der Waals heterostructure based nanocircuits in piston-cylinder hydrostatic pressure cells with a dedicated sample holder design. This technique opens the way to conduct transport measurements on nanodevices under pressure using up to 12 contacts without constraints on the sample at the fabrication level. Using transport measurements, we demonstrate that a hexagonal boron nitride capping layer provides a good protection of van der Waals heterostructures from the influence of the pressure medium, and we show experimental evidence of the influence of pressure on the interlayer coupling using weak localization measurements on a transitional metal dichalcogenide/graphene heterostructure.

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INTRODUCTION

The discovery of graphene along with other layered crystals led to the emergence of a novel field in material science. ¹⁻³ Van der Waals (vdW) heterostructures, composed of multiple crystal layers with a thickness of a few atomic layers each, exhibit various electronic properties unprecedented in the bulk versions of the component materials. The novelty in these heterostructures is twofold. First, atomically thin layers show novel electronic properties compared to their bulk counterparts, such as the massless Dirac fermion nature of electrons in graphene, ⁴ a direct-to-indirect semiconductor bandgap transition in MoS₂ with decreasing number of layers, ⁵ the magnetic structure of CrI₃ that depends on the number

of layers,⁶ or the appearance of a topological insulating phase in single layer WTe₂.⁷⁻¹² Second, combining these layers into heterostructures leads to overlapping atomic orbitals in the neighboring layers, which may cause drastic changes in the electronic structure of the system. This often originates from the different materials of the components, e.g., the emergence of inherited proximity spinorbit coupling (SOC),¹³⁻²⁰ ferromagnetic ordering in graphene,²¹⁻²⁴ or in transition metal dichalchogenides.^{25,26} A moiré superlattice can also emerge if the component layers have unit cells of almost the same size, as in the case of graphene with hexagonal boron nitride (hBN), leading to the appearance of secondary Dirac points, Hofstadter butterflies, and Brown–Zak oscillations in transport.²⁷⁻³³

The interlayer coupling strongly depends on the interlayer distance, which is determined by the vdW interaction that keeps the layers together. However, by applying hydrostatic pressure on these heterostructures (see Fig. 1), the interlayer coupling can be tuned, which strongly influences the electronic structure and thereby the physical properties of these heterostructures. The potential interest of tuning this parameter is demonstrated in various theoretical works; 13,36-43 however, several technological challenges are to be solved for the realization of transport measurements on nanodevices under pressure.

Hydrostatic pressure cells have widely been used in solid state physics on bulk samples. Changing the pressure can not only tune the wavefuction overlap but can lead to structural changes in the crystal, as, e.g., in 2H_c-MoS₂, where layer sliding structural transition and metal-insulator transition take place. 44-48 Pressure is an experimental knob to modify different correlated states and induce quantum phase transitions from charge density wave to superconductivity 49-52 or from paramagnetism to ferromagnetism.

All the experimental works on transport measurements with pressure manipulation cited above used samples that remained in the macroscopic size range (0.1 mm), even in the case of carbon nanotubes, the sample was on a buckypaper of macroscopic size.⁵

Meanwhile, the dimensions of vdW heterostructure based nanocircuits are microscopic and conventionally a very different measurement method is used to carry out transport measurements, often involving wire bonding on standard ceramic chip carriers or circuit boards. The spatial dimensions of the conventional solutions are considerably larger than the available space in a common hydrostatic pressure cell, which is limited to technological constraints in order to achieve high hydrostatic pressure values without damaging the cell components. Therefore, the standard measurement techniques of nanocircuits do not work in a hydrostatic pressure environment, and special setups are needed.

The first pioneering papers about such experiments already showed the potential of this technique, where they managed to

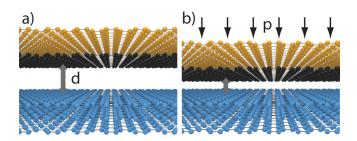


FIG. 1. Schematic illustration of the effect of hydrostatic pressure on an arbitrary van der Waals heterostructure. (a) The interlayer distance d is determined by the van der Waals interaction that keeps the layers together. (b) By applying an external pressure p, the heterostructure compresses, thus decreasing the distance and increasing the interaction strength between the component layers.

tune the superconducting critical temperature of a twisted bilayer graphene structure or change the magnetization alignment of a thin magnetic structure. ^{59–61} In these studies, the vdW nanocircuits were fixed and electrically connected using silver paint directly to the pressure cell feedthrough wires without any intermediate structure. Although it can work, this technique has several limitations: it requires very accurate manual work, and electrostatic discharge protection is not fulfilled during silver paint contacting. Furthermore, precise orientation of the chip inside the cell also remains challenging, which is required as the proper relative orientation of the vdW heterostructures to the magnet axes play an important role in many measurements. 62,63 Therefore, a systematic, safe, and easy method to incorporate nanocircuit measurements into a hydrostatic pressure cell environment is still missing. In this paper, we present such a new method and a dedicated sample holder for measurements of nanocircuits using wire-bonding up to 12 electric lines with controlled and reproducible positioning of the chip on the cell plug. Our method is fully compatible with the standard sample fabrication methods and does not require a specific design at the fabrication level unlike previous studies,⁵ which makes hydrostatic measurements possible on any sample below ca. 3 mm lateral size, equipped with bonding pads.

In the following, after detailing the specific technical requirements of transport measurements on a nanocircuit under pressure, we introduce our dedicated sample holder head and its working mechanism. Then, we present two different examples of hydrostatic pressure applied on van der Waals heterostructure based nanocircuits using our new method. The first measurement demonstrates that an hBN cover layer provides an ideal isolation between the sensitive 2D electron system and the pressure transfer medium. The second one gives evidence that the interlayer course, changed significantly in graphene/TMDC heterostructures by the changed in our setup.

SAMPLE HOLDER DESIGN

Piston-cylinder pressure cells [see Fig. 2(a) and the Appendix for a detailed description] have widely been used before to measure transport through macroscopic samples. Contacting electric wires to macroscopic samples using silver paste for two- or four-terminal measurements is feasible by hand, although it requires operator experience. Meanwhile, transport measurements on nanocircuits built on conventional Si/SiO2 substrates can be far more challenging.

First, measurements of a complicated sample may involve several contacts on the chip surface, occasionally contacting the doped Si substrate on the chip bottom as a global back gate as well. There might also be multiple equally interesting devices on the same chip, often resulting in more than 20 contacts on a single chip. Second, contact pads usually created by electron lithography on these nanocircuits vary in size typically between 20 and 200 m with a spacing between them of the same length scale. Contacting such electronic contact pads by hand using silver paste is hardly feasible. It is possible to design the chip with enlarged contact pads and placed far from each other (thus limiting the number of available contacts), 59,60 but even in this case, application of silver paste puts the sample at considerable risk of accidentally contaminating the chip surface or of uncontrolled electrostatic discharge (ESD).

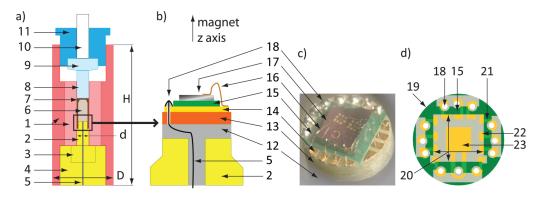


FIG. 2. (a) Schematic side view of a clamp-type two-layer pressure cell without the detailed sample holder head. The cell dimensions are H ... 62 mm, D ... 25 mm, and d ... 6.5 mm. 1. NiCrAl/CuBe double layered cell wall. 2. CuBe plug. 3. WC plug backup. 4. CuBe lower screw. 5. Electric feedthrough, marked by gray across the yellow parts. 6. High pressure volume (HPV), filled with pressure medium. 7. Teflon cup. 8. WC piston. 9. WC piston backup. 10. WC push rod. 11. CuBe upper screw. Additional sealing rings (not drawn) prevent oil leak from the HPV. (b) Detailed schematic side view of the sample holder head, as marked by the black rectangle on panel (a). (c) Corresponding bird's-eye view of the top of the sample holder head with a chip attached on it and bonded to the electric contacts. Marks 2 and 5 are the same as in panel (a). 5. Feedthrough diameter varies between 0.7 and 1.0 mm between plug instances. 12. Epoxy bedding. 13. PCB core layer. 14. PCB top Cu layer with Ni/Au finish. 15. PCB solder stop layer. 16. Bonding wires connecting the PCB bonding pad and the lithographed contact pads of the chip. 17. Nanocircuit chip with the heterostructure on its surface. 18. Non-plated through-holes (NPTHs) and soldered electric feedthrough lines. (d) Schematic top view of the PCB design (12-line version). 19. The useful PCB diameter is 5.1 mm. 20. Central area [ca. 2.6 mm (w) 2.4 mm (h)] where the chip is placed. Maximal chip size ca. 2.4 2.2 mm². 21. PCB traces connecting the soldered feedthrough lines to the bonding pads. 22. Bonding pads. 23. Au backplate to contact the chip backside, if needed.

This dangerous situation is repeated if the sample needs to be taken off the sample holder plug temporarily and placed back later (e.g., to conduct an auxiliary measurement on it), needing re-connection of the lithographed contacts. Third, vdW heterostructures are anisotropic samples by design. Therefore, chip orientation relative to the cryostat magnet axes plays an important role and needs to be controlled and maintained during the experiments, which can last several days with multiple thermal cycles as well. Orientation reproducibility is also required in case of a repeated installation of the sample on the plug.

We developed a dedicated sample holder head to satisfy these requirements. The head consists of the plug, the electric feedthrough wires embedded in an epoxy filler, and a printed circuit board (PCB). The sample is fixed on the PCB using conducting or insulating double sided tape and is contacted using wire-bonding to the PCB contact pads. Using the standard wire-bonding technology, one can use nanocircuits without any special modification at the lithography level and with several bonding pads of the usual size.

A schematic view of the sample holder is depicted in Fig. 2(b), whereas in Fig. 2(c) a bird's-eye view photograph is shown. 36 AWG (American wire gauge, diameter D 130 m) phosphorbronze electrical wires (5) are used to connect the PCB to external connectors. Stycast 2850FT epoxy filler with catalyst 9 (12) is used to seal the plug through-hole around the feedthrough wires. Its role is not only to seal but also to support the PCB (layers 4-6) mechanically, finally, to fill the space below it to avoid air bubble formation that can lead to mechanical shock waves when the bubbles collapse during pressurization. The epoxy is filled in the plug through-hole but not in the hole of the plug backup or of the lower screw. The electric feedthrough wires penetrate the PCB core layer (13) via non-plated through-holes (NPTHs, 18) and are

soldered to traces (14) on the top of the PCB that lead to bonding pads under a solder stop layer (15) used for isolation from the possibly conducting backside of the chip (17). The chip contacts are connected via wire-bonding (16). The PCB surface is leveled perpendicular to the plug axis, thus securing the chip in a well defined orientation with respect to the cryostat magnet axes. Leveling the RPCB surface is a delicate handwork at the sample holder fabrication time, but using the already soldered wires' rigidity, it can be done with less than 5 tilt. The epoxy filler is applied after this step.

We developed three different versions of the PCB design with 8, 10, and 12 contacts, of which the 12-line version is shown in Fig. 2(d). The useful diameter of the PCB is limited by the inner diameter of the cell and the thickness of the Teflon cup to 5.1 mm (19). A clearance of 0.25 mm is also added along the perimeter for PCB manufacturing reasons which is scraped away as the last step of the sample holder production. The central part (20) of the presented PCB supports the chip itself on an area of 2.6 2.4 mm², which depends on the PCB design, up to 3.5 3.5 mm² offered by the 8-line version. The finite space requirement of the wire bonding procedure and a tolerance of positioning the chip manually by tweezers altogether limits the chip size to a slightly smaller size (by ca. 0.1 mm on each side) without the risk of shorting any of the contacts or obscuring the bonding pads. The feedthrough wires penetrate the PCB core layer through the NPTHs lined up at the top and left side of the PCB (18). Traces (21) link the NPTHs to the bonding pads (22) under the solder stop layer (15) to avoid shorts to the chip substrate. Special care should be taken at the sample holder fabrication time to avoid solder on the bonding pads, which makes the bonding wires unable to stick on the pad surface. Therefore, the bonding pads, covered by Ni/Au finish and enlarged as much as possible to maximize re-usability, are as

Another advantage of the dedicated PCB design is that as long as not exposed to the pressure medium, or after cleaning it in acetone, this sample holder head works just as any regular measurement setup of nanocircuits and can be a substitute for it. In addition, it is possible to mass fabricate the sample holder head prior to experiments and if multiple sets of the plug, plug backup, and lower screw are available, parallel investigation of different samples is also feasible, reducing the need of de-connecting and re-connecting samples.

MEASUREMENT RESULTS

In this section, we present measurements on the effect of pressure on samples that were not specifically designed for pressure experiments. Despite their general design, we could still incorporate them in our setup, which is the main advantage of our method.

Due to its monolayer nature, the electronic quality of a graphene flake is largely affected by the presence of charged impurities on its surface.⁶⁴ This contamination induces a rough electrostatic potential that leads to scattering mechanisms that reduce the charge carrier mobility and the mean free path in the sample, which decreases the visibility of many transport phenomena of interest. Such contamination is expected to occur when the graphene flake is exposed to the kerosene used as a pressure medium in the experiment since it is an organic liquid with many components of various chemical structures. Indeed, our previous experience shows that exposing a single graphene layer to kerosene degrades its electronic quality even to a point where the charge neutrality point (CNP) is not visible anymore in the transport measurements. We studied and hereby demonstrate that encapsulation with hexagonal boron nitride (hBN) flakes of thickness in the order of 10 nm can protect the graphene layer from the pressure medium, and in such a heterostructure, the presence of kerosene does not affect substantially either the contact resistances or the charge carrier mobility measured in twoterminal measurements.

The studied devices were fabricated on a Si/SiO₂ substrate using the common dry stacking assembly method.⁶⁵ The shape of the samples was defined using reactive ion etching and Cr/Au side contacts were fabricated in a separate lithography step.3 Two terminal measurements were performed at f ... 177 Hz with V_{AC} ... 100 V excitation voltage using standard lock-in technique and external lownoise current amplifier. The doped Si substrate is used as a global backgate electrode.

Device A consists of a single layer of graphene encapsulated in multilayer top and bottom hBN flakes, see Figs. 3(a) and 3(b), and was shaped into a stripe of dimensions W ... 1.7 m and

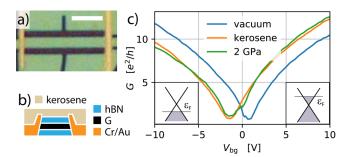


FIG. 3. Measurements on device A. (a) Optical micrograph. The surface of the top hBN flake is marked by green, the electrical contacts are on the two sides, and the dark blue stripes are the surface of the bare SiO2 chip, where etching shaped the heterostructure. Shaping also included cutting the graphene flake beneath the top hBN flake (not visible) in the upper and lower parts in the image, therefore the current in the detailed two-terminal measurement only flows along the horizontal long middle section of dimensions $\it W$... 1.7 m and L ... 12.7 m. The scalebar (white) is 5 m. (b) Schematic side view of the stack as it is placed on the SiO2 surface. A single layer graphene (G) sheet is encapsulated between hexagonal boron nitride (hBN) layers and contacted to Cr/Au electrodes via standard line contacts. (c) Comparison of two-terminal conductance vs back gate voltage measurements at 4 K. Vacuum: the sample has never been exposed to kerosene. Kerosene: in the kerosene environment, without additional pressure. 2.5 GPa: in the kerosene environment, under 2.5 GPa pressure. The top hBN flake protects the graphene layer and its electronic contacts from contamination in the kerosene environment. Left (right) inset: schematic view of the Fermi energy in the band structure of graphene as it is tuned in the valence (conduction) band by the gate voltage.

 $L \dots 12.7$ m. In Fig. 3(c), we present two-terminal conductance measurements at 4 K temperature in different environments as a function of the gate voltage: first, before any exposure to kerosene, in them in kerosene without and then in kerosene without applying external pressure, and finally applying 2.5 GPa pressure. The charge neutrality point (CNP) is shifted slightly, from 0.7 to 1.5 V after the exposure to kerosene, but did not change during pressurization. For the extraction of the charge carrier mobility and the series resistance of the contacts, a curve fitting was performed using a parallel plate capacitor model to determine the charge carrier density. The mobility stayed within a 10% range between the cases, reaching 55 000 and 50 000 cm²/V s for electrons and holes, respectively. The contact resistances remained in the 220-340 m range without any systematic trend. As the variation of these parameters between subsequent thermal cycles of the same heterostructure is usually in the same order of magnitude, we conclude that the presence of the kerosene does not change the mobility of the sample nor the quality of the edge contacts. We have performed similar measurements on various devices with different van der Waals heterostructures using the hBN protection layer on the top and we found that the protection property of hBN flakes is generic.

As can be seen from Fig. 3, the transport properties of single layer graphene are not substantially changed under hydrostatic pressure. This changes markedly for multi-layer systems. One of the large potentials of the experiments under hydrostatic pressure lies in tuning interfacial proximity interactions in vdW heterostructures. After demonstrating the possibility of protecting the heterostructures

in the hydrostatic pressure cell environment, we show that the applied pressure can result in an observable change in the transport properties of a graphene sample coupled to a WSe₂ crystal. In Fig. 4(a), the optical micrograph of device B is shown, where the measured segment of $W \dots 1 \mod L \dots 5 \mod$ is highlighted by a black line. The schematic side view of the sample is shown in Fig. 4(b), which is composed of a bottom multilayer WSe₂ flake, a single graphene flake, and a multilayer hBN protecting flake on the top. The device is also equipped with a topgate, separated from the heterostructure and its contacts by an insulating MgO layer, but this was not used in the experiments presented here.

In such transitional metal dichalcogenide (TMDC)/graphene heterostructures, it was found that the TMDCs can induce a spinorbit coupling (SOC) in graphene via proximity effect. 14-The strength of the SOC depends on the layer distance, which is expected to be tuned by hydrostatic pressure. 13 The presence of the SOC can be detected via magneto-conductance (MC) measurements, i.e., the change in the conductance vs the out of plane magnetic field. In case of no or weak SOC, the MC curves exhibit a conductance dip called weak localization (WL) effect, whereas if a strong SOC is present, a conductance peak appears, which is the weak anti-localization (WAL) effect. Figure 4(c) shows MC curves in the kerosene environment at 4 K temperature, one with no pressure, the other with 2.5 GPa pressure. While a prominent WAL peak is present in the latter case, no significant peak can be found in the no pressure case and a WL dip is measured. Although the formation of the WAL peak might be related to changes in the intervalley scattering time due to the Berry phase in graphene, we suspect that it is rather related to the increased spin-orbit coupling strength in graphene. The detailed analysis goes well beyond the scope of this manuscript and is discussed elsewhere.

The sample was not designed specifically to the needs of the pressure cell; however, it could be incorporated into our setup. Three devices were formed on a single chip, each with a Hall bar

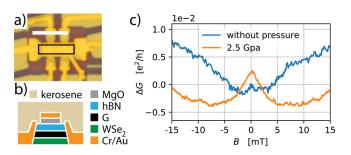


FIG. 4. Measurements on device B. (a) Optical image of the device. The current in the detailed measurement flows along the longest segment, highlighted by the black line. The scalebar is 5 m. (b) Schematic side view of the stack as it is placed on the SiO_2 surface. The graphene layer (G) is placed on a multilayer WSe $_2$ flake and covered by a multilayer hBN. An additional topgate covers partially the heterostructure separated by an insulating MgO layer, but it was not used in the presented measurements. (c) Two-terminal magneto-conductance curves in the kerosene environment under ambient pressure and 2.5 GPa, the latter shifted by p2 10 $^3e^2/h$ for clarity. A clear enhancement of weak antilocalization is visible indicating an enhancement of the proximity-induced spin–orbit coupling in the graphene layer.

shape with several electrical contacts and local top gates, with 23 contacts in total on the chip surface. A contact pad on the chip surface was 200 150 m² with a spacing of 30 m. This is a size scale that is really challenging to bond using silver paint without accidentally connecting neighboring contact pads or even contaminating the nanocircuit itself. The bounding box of the patterned area extended to 2 2 mm, which needs precise dicing of the chip in order to fit on our sample holder. We note that the performed measurements included several thermal cycles with multiple re-bonding of the wires and lasted for several weeks in total without any problem in the sample holder head.

CONCLUSION

In this work, we presented a novel method to tune the interlayer coupling in vdW heterostructures postfabrication using hydrostatic pressure. This method enables electronic transport measurements on vdW heterostructures while adding the possibility of tuning the interlayer coupling in them at measurement time. This method allows controlled and reversible fixation of the chip and up to 12 wire-bonding connections to it, which makes hydrostatic pressure studies a lot easier than existing alternatives. We showed experimental evidence of the applicability of hBN crystal flakes as a top layer in order to protect the underlying layers from the pressure medium. Changing interlayer coupling has a measurable effect on the electrical transport of a sensitive heterostructure, as has been demonstrated by weak localization measurements on a graphene/WSe2 heterostructure. Thus, our study provides a new experimental knob, which can be used to tune vdW heterostructure no based nanodevices and opens the way toward the highly anticipated ξ pressure studies not only for vdW heterostructures, but also for any other nanocircuit-based physical systems.

AUTHORS' CONTRIBUTIONS

B.F, A.M., Z.K-K., and E.T developed the pressure cell setup with the guidance of Sz.Cs and I.K. The samples were fabricated by S.Z., D.I., and M.K. with the support of P.M. B.F. and A.M. did the measurements. The manuscript was written by B.F., P.M., and Sz.Cs. All authors discussed on the manuscript. K.W. and T.T. grew the hBN crystals. The project was guided by Sz.Cs., P.M., and C.S.

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APPENDIX: PISTON-CYLINDER PRESSURE CELLS

Although the method presented in this paper works well with any type of piston-cylinder pressure cell, we present in the following, as an example, the general build-up and working principle of one specific cell that we used, made by C&T Factory, Japan [see Fig. 2(a) for a schematic side view].

1. Working principle

The sample is placed inside a cylindrical high pressure volume (HPV) at the core of the cell, which is filled with a pressure medium, then compressed in a hydraulic press. After clamping the cell at the target pressure, it can be removed from the press and used in any transport measurement setup, e.g., attached to a cryostat dipstick and cooled down to cryogenic temperature. At the end of the measurements, to release the pressure or to set a different one, the cell should be warmed up and placed in the hydraulic press again for a reverse process.

The side of the HPV cylinder is supported by the shell of the pressure cell, whereas the top and bottom ends are closed by a piston and a plug element, respectively, both clamped by two screws. Transport experiments can be done on the sample via an electric feedthrough of the plug. Our cell has an outer diameter of $D \dots 25 \,\mathrm{mm}$ and a height $H \dots 62 \,\mathrm{mm}$, which is small enough to fit in the bore of many magnets used in cryogenic systems allowing measurements under magnetic field, and also in our VTI measurement setup, thus offering a temperature range of 1.5-300 K.

2. Build-up of the cell

The cell wall is composed of two cylindrical shells made of NiCrAl and CuBe, respectively, see mark (1) in Fig. 2(a). The HPV (6) is situated in the central part of the device in a Teflon cup (7), which opens at the lower end and encloses the pressure medium along with the sample. The volume is closed on the lower end of the Teflon cup by the sample holder plug (2), the plug backup (3), and clamped by the lower screw (4). Our special sample holder, discussed below, is fabricated on the top of the plug (2), and the sample is placed on the top of the sample holder, as depicted in Fig. 2(b). The yellow parts are secured in place during setup assembly prior to pressurization. Transport measurement inside the cell is carried out via the electric feedthrough (5), marked by gray across the yellow parts. At the top end of the HPV, the piston (8) and the piston backup (9) move downwards in the cell during pressurization, as the push rod (10) transfers the load from an external pump on the Teflon cup and the HPV compresses. To fix the pressure inside the HPV at the end of the pressurization process, the upper screw (11) is tightened. Finally, this screw takes the load as the pressure in the external press is released. For sealing, a CuBe obturator ring is placed between the Teflon cup (7) and the piston (8), whereas on the lower side, a CuZn obturator is supported by a

narrow shoulder on the plug at the opening of the Teflon cup. The choice of a softer material for the lower obturator ring aims to avoid it sticking inside the cell during disassembly after releasing the pressure, because sticking can lead to the break of the sample holder head and prevents its potential reusability.

3. Pressure medium

The HPV inside the Teflon cup [6 in Fig. 2(a)] is filled by a pressure medium, usually an organic compound. We use the Daphne 7373 kerosene compound produced by Idemitsu Co., Japan. This type of oil has several properties that make it a good choice as a pressure medium, as studied before. 74,75 First, it solidifies at room temperature at a relatively high, 2.2 GPa pressure. Up to this pressure, hydrostaticity (isotropy and uniformity) of the pressure is assured, but the sample has to be at room temperature. Second, the pressure reduction from room temperature to cryogenic temperatures is low, around 0.15 GPa, independent of the room temperature pressure above 0.5 GPa. Third, the pressure reduction occurs continuously and gently along the cooling cycle, including the freezing of the oil. This helps to avoid problems due to the mechanical shock occurring at a sudden freezing, which could potentially break the bonding wires, the PCB, or the sample itself as well. To further reduce the chance of mechanical shocks, the temperature ramp rate is limited to 3 K/min above 150 K, where the freezing occurs.

DATA AVAILABILITY

The data that support the findings of this study are openly able in the Zenodo repository at https://doi.org/10.5281/ ido.4773824, Ref. 76. available in the Zenodo repository at https://doi.org/10.5281/ zenodo.4773824, Ref. 76.

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